



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re patent application of

Tomohiro Sakai, et al.

Serial No.: 10/695,439

Group Art Unit: 2814

Filing Date: October 29, 2003

Examiner: Weiss, Howard

For: ELECTRODE FOR P-TYPE SiC

Honorable Commissioner of Patents
Alexandria, Virginia 22313-1450**INFORMATION DISCLOSURE STATEMENT**

Sir:

Under the provisions of 37 CFR §1.97 through §1.98 and pursuant to applicants' duty of disclosure under 37 CFR §1.56, applicants respectfully bring the following documents cited in the Japanese Office Action in a counterpart foreign application and listed on the attached form PTO-1449, to the attention of the Examiner in charge of the above-identified application. Copies of the listed documents are provided herewith for the convenience of the Examiner.

In compliance with the requirements of 37 CFR §1.98(a)(3), as a concise statement of relevance, English Abstract are attached to all of the references.

This citation does not constitute an admission that the references are relevant or material to the claims. They are only cited as constituting related art of which the applicants are aware.

Submitted herewith is the Information Disclosure Statement fee of \$180.00.

It is respectfully requested that the listed references be considered by the Examiner and formally made of record in this application.

Please charge any deficiencies in fees and credit any overpayment of fees to Attorney's Deposit Account No. 50-0481.

Respectfully submitted,

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Date: 7/12/07
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INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)



Docket Number (Optional)

T36-159872M/SW

Application Number

10/695,439

Applicant(s)

Tomohiro Sakai, et al.

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October 29, 2003

Group Art Unit

2814

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

U.S. PATENT APPLICATION PUBLICATIONS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						YES	NO
	2002-252233	09/06/02	JAPAN			AB5	
	04-225568	08/14/92	JAPAN			AB5	
	04-196420	07/16/92	JAPAN			AB5	

OTHER DOCUMENTS

(Including Author, Title, Date, Pertinent Pages, Etc.)

Japanese Office Action dated February 15, 2006

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.